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EFFECTS OF ELECTRON IRRADIATION AND TEMPERATURE ON 1Ω-cm AND 10Ω-cm SILICON SOLAR CELLS

C. NICOLETTA

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ABSTRACT

 $1\,\Omega\text{-cm}$ and $10\,\Omega\text{-cm}$ Silicon solar cells, manufactured by AEGTelefunken, were exposed to 1.0 MeV electrons at a fixed flux of 10^{11} e/cm²-sec and fluences of 10^{13} , 10^{14} and 10^{15} e/cm². I-V curves of the cells were made at room temperature, -63° C and $^{+}143^{\circ}$ C after each irradiation. A value of 139.5 mw/cm² was used as AMO incident energy rate per unit area. The $10\,\Omega\text{-cm}$ cells appear more efficient than $1\,\Omega\text{-cm}$ cells after exposure to a fluence greater than 10^{14} e/cm². The 1.0 MeV electron damage coefficients for both $1\,\Omega\text{-cm}$ and $10\,\Omega\text{-cm}$ cells are somewhat less than those for previously irradiated cells at room temperature. The values of the damage coefficients increase as the cell temperatures decrease. Efficiencies as pertaining to maximum power output, are about the same as those of n on p silicon cells evaluated previously.



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EFFECTS OF ELECTRON IRRADIATION AND TEMPERATURE ON $1\,\Omega\text{-cm}$ AND $10\,\Omega\text{-cm}$ SILICON SOLAR CELLS

GENERAL INTRODUCTION

 1Ω -cm and 10Ω -cm solar cells, manufactured by AEG-Telefunken, West Germany, were irradiated with 1.0 MeV electrons. These cells were of the same type reported on earlier for proton irradiation, (Ref. 1).

From an engineering point of view, the effect of radiation on minority carrier lifetimes is of prime importance in determining the response of the cell. Electrons with energies >1.0 MeV cause damage to the base region of the cell affecting carrier lifetimes.

The damage is due to the energy given up by the incident particle in passing through the material. For solar cells, this energy forms damage centers, which shorten the minority carrier lifetimes and reduce the short circuit current. Since generally electron penetration is much greater than for protons, a 1.0 MeV electron will pass through a 300μ thick silicon solar cell, (Fig. 1). In doing so it gives up equal increments of energy along its path, and therefore produces damage centers at a uniform rate. Thus, a linear dependence between short circuit current and minority carrier diffusion length can be assumed. This is not the case for 1.0 MeV protons striking 300μ thick cells, since they are absorbed within the cell, (Ref. 1). From the expression for carrier lifetime with particle fluence, (Ref. 2)

$$\frac{1}{\tau} = \frac{1}{\tau_0} + K\Phi \tag{1}$$

one obtains the electron damage coefficient, K.

Since the diffusion length is related to the lifetime by

$$L = \sqrt{D\tau} \tag{2}$$

where D is the diffusion constant, we have

$$\frac{1}{L^2} = \frac{1}{L_0^2} + K\Phi \tag{3}$$

where \boldsymbol{L}_0 is the initial diffusion length and $\boldsymbol{\Phi}$ the fluence.

The damage coefficient is a measure of cell degradation at a particular energy and temperature for incident particles.

As in the previous work with proton irradiation, these cells were exposed to electrons at room temperature and the $I-\overline{V}$ curves were made approximately at room temperature, -65° C, and $+145^{\circ}$ C. Fluence levels were selected to fit in with previous tests and were in the range of from 10^{13} e/cm² to 10^{15} e/cm².

Solar cell efficiencies are obtained directly from the $I-\overline{V}$ curves, and, as in the case of protons, represent the single most important quantity for power conversion in space. The solar cell efficiency η is defined as maximum power input

power input

and is expressed by the equation, (Ref. 2)

$$\eta = \frac{I_{\text{sc}} \frac{q}{kT} V_{\text{mp}}^2 \left(1 + \frac{I_{\text{o}}}{I_{\text{sc}}} \right)}{\left(1 + \frac{q}{kT} V_{\text{mp}} \right) \text{ A (AMOS.C.)}}$$
(4)

where

I_{sc} - short circuit current

q - electron charge

k - Boltzmann's constant

T - absolute temperature of cell

 V_{mp} - value of voltage at max. power

I - saturation current

A - solar cell area

(AMOS.C.) - air mass zero solar constant

From eq. (4) it is apparent that efficiency increases with decreasing temperature and decreases with decreasing short circuit current. Short circuit current in turn decreases with increasing fluence.

EXPERIMENTAL TECHNIQUES

In order to assure electron beam stability, homogeneity, and size, these experiments were conducted using a small portable chamber under low vacuum. The electron beam passed in a straight horizontal line into the chamber from the accelerator and was vertically swept at ~400 Hz. The effective beam size at the target was about 38 cm by 7 cm. The solar cells were attached to a temperature controlled brass sample holder by silver epoxy cement. In the

first exposure batch, nine cells were mounted on the holder with Faraday cups centrally located and at one end of the holder. In the second batch, twelve cells were similarly exposed. The sample chamber was attached to the horn assembly at the end of the accelerator drift tube. The electron beam passes through a 50μ thick titanium window before impinging on the cells. Using energy loss data for Aluminum from Berger & Seltger's tables (Ref. 3) and correcting for titanium, we found that for 1 MeV electrons, approximately 35 KeV or about 3% of the energy is lost in the window.

Cold gaseous nitrogen was circulated through the brass sample holder for the low temperature measurements which were made first. Heaters (350 watt) were used on the input gas lines to the holder to obtain the high temperatures. A Cu-Constantan thermocouple was mounted on the sample holder to monitor solar cell temperature. Due to thermal limitations, it was only possible to heat the samples to $\pm 145^{\circ}$ C.

After particle irradiation, the vacuum chamber was removed from the horn assembly of the accelerator and brought to ambient atmosphere. A 1.6 cm thick glass plate was then placed over the chamber opening in order to irradiate the cells for $I-\overline{V}$ measurements. The variation in the electron beam energy supplied by the Van de Graaff accelerator was about $\pm 1.0\%$. The flux used in all irradiations was 10^{11} e/cm²-sec, and was far more uniform (< $\pm 10\%$ variation) over the target area than the proton flux in the previous experiments (Ref. 1).

An X-25 solar simulator using a 3000 watt Xenon lamp was used in making the I- \overline{V} measurements. A value of 139.5 mw/cm² was maintained as AMO (Air Mass Zero) during all measurements. The variation of the light beam over the samples was about $\pm 2.0\%$. A Spectrolab D550 electronic load coupled to an x-y platter provided the I- \overline{V} curves.

The solar cells are (2×2) cm N/P silicon 300μ and 200μ thick. They included partially and fully covered cells with about 150μ of fused silica. Each cell has four leads to reduce resistance losses, two on the buss bar and two on the Ti(Pd)Ag layer on the back of the cell.

The first batch of 9 cells irradiated, consisted of:

three 10Ω -cm (300μ) uncovered

three 10Ω -cm (300μ) covered

three $10\,\Omega\text{-cm}$ (200μ) uncovered.

These were irradiated to fluences of $4.2 \cdot 10^{13}$, 10^{14} , 10^{15} e/cm².

The second batch of 12 cells consisted of:

three 1Ω -cm (300μ) covered three 1Ω -cm (300μ) 50% covered three 10Ω -cm (300μ) 50% covered three 1Ω -cm (300μ) uncovered

irradiated to fluences of 10¹³, 10¹⁴, and 10¹⁵ e/cm².

After each of the above fluences was reached, $I-\overline{V}$ curves of each sample were made at room temperature, \sim -63°C, and \sim 145°C, immediately after irradiation to minimize annealing effects.

The energy loss by the 1.0 MeV electrons in passing through the 150μ fused silica coverslides is about 65 keV, (Ref. 4), which is negligible. That is to say, damage for both covered and uncovered cells should be similar.

RESULTS

Characteristic I- \overline{V} curves, showing solar cell power output in watts, were made for each measurement. Figures 2-15 show typical I- \overline{V} curves for the seven different types of solar cells before irradiation and again after 10^{15} e/cm². The I- \overline{V} curves for intermediate fluences of 4.2· 10^{13} e/cm² and 10^{14} e/cm² have been omitted in this report.

As in the case of the cells used for proton irradiation, these cells exhibited the same room temperature efficiency before irradiation to within 0.6%.

Table 1 gives the values of the open circuit voltage and short circuit current with electron fluence and sample measurement temperature. The efficiencies of the cells are found to increase with lower cell measurement temperature, and to decrease with higher cell measurement temperatures. Note the efficiencies of both 1Ω -cm and 10Ω -cm covered and uncovered cells are about the same, $\sim 7.0\%$ after 10^{15} e/cm² at 25° C, see figures 16-19. The 10Ω -cm cells appear slightly more efficient above 10^{14} e/cm² than the 1Ω -cm cells. Luft and Rauschenback observed similar results on Texas Instruments I/P cells, (Ref. 5), as did Cherry and Slifer (Ref. 6).

Relative efficiencies with fluence are plotted in figure 23 for $10\,\Omega$ -cm Heliotek cells (Wilsey, Ref. 7) and for $10\,\Omega$ -cm cells (Reynard, Ref. 8). The relative efficiencies of the 1Ω -cm cells are seen to be less than the $10\,\Omega$ -cm Heliotek and AEG cells.

Efficiencies before irradiation, for the 250μ thick N/P cells measured at 145° C, were found to be $\sim 5.0\%$, and compare closely with Lewis and Kirkpatrick's results, (Ref. 9).

The values of the electron damage coefficients are given in table 2. Values of initial diffusion lengths for N/P blue sensitive silicon solar cells are taken from Rosenzweig, (Ref. 10). In all cases, note that the damage coefficients increase with decreasing temperature. The values of the present AEG-Telefunken cells appear to be less than values for cells irradiated previously by 1 MeV electrons at room temperature, (Ref. 11).

Comparison of efficiencies of these electron irradiated cells with previously irradiated cells is about the same. After 10^{15} e/cm², the present AEG cells are about 0.5% lower in efficiency than n on p (150 to 280) in thick cells, (Ref. 12).

Although damage coefficients vary somewhat between covered and bare cells of the same type, this difference is considerably less than the difference between 1Ω -cm and 10Ω -cm cells.

CONCLUSIONS

- (1) Above a fluence of $10^{14}~\rm e/cm^2$, the $10\,\Omega$ -cm cells appear more efficient than $1\,\Omega$ -cm cells.
- (2) Damage coefficients for both the 1Ω -cm and 10Ω -cm cells, measured at room temperature, are less than values evaluated for earlier cells.
- (3) Damage coefficients increase with decreasing measurement temperature.
- (4) Efficiencies of the AEG cells are about the same, or slightly less, than those of earlier irradiated N/P cells.

ACKNOWLEDGEMENTS

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Table 1

	80-7 (1Ω-cm bare)	81-10 (1Ω-cm cov)			
fluence P/cm²	V _{oc} I _{sc} T V _{oc} I _{sc} T V _{oc} I _{sc} T mv ma °C mv ma °C	V _{oc} I _{sc} T V _{oc} I _{sc} T V _{oc} I _{sc} T mv ma °C mv ma °C mv ma °C			
0	590 132 25 730 127 -62 330 140 146	590 128 25 715 124 -66 370 136 145			
10 ¹⁴	565 119 25 750 110 -63 315 130 143	555 120 25 650 114 -63 335 130 143			
10 ¹⁵	530 98 24 705 83 -64 260 110 148	515 102 24 615 91 -62 280 111 148			
	152-3 (10Ω-cm 50%)	81-4 (1Ω-cm 50%)			
fluence P/cm²	V _{oc} I _{sc} T V _{oc} I _{sc} T V _{oc} I _{sc} T mv ma °C mv ma °C mv ma °C	V _{oc} I _{sc} T V _{oc} I _{sc} T V _{oc} I _{sc} T mv ma °C mv ma °C			
0	550 139 25 625 134 -63 270 146 146	595 132 25 725 126 -62 330 139 144			
10 ¹⁴	525 130 25 665 118 -64 270 142 143	570 123 25 755 112 -63 330 135 145			
10 ¹⁵	495 116 25 670 96 -67 215 125 148	530 101 25 735 85 -67 260 114 148			

7

Table 1 (Continued)

	152-18 (10Ω-cm cov)	151-16 (10Ω-cm bare)		
fluence P/cm ²	$egin{array}{cccccccccccccccccccccccccccccccccccc$	V _{oc} I _{sc} T V _{oc} I _{sc} T V _{oc} I _{sc} T mv ma °C mv ma °C		
0	545 146 25 630 142 -60 270 155 140	550 142 25 625 136 -60 270 147 140		
4.210^{13}	545 138 25 655 126 -67 270 147 143	540 134 25 660 124 -62 265 139 143		
10 ¹⁵	495 119 26 665 104 -64 225 133 144	490 119 26 640 103 -64 220 130 144		
	150-5 (10Ω-cm 200)			
fluence P/cm ²	V_{oc} I_{sc} T V_{oc} I_{sc} T V_{oc} I_{sc} T mv ma $^{\circ}C$ mv ma $^{\circ}C$	V _{oc} I _{sc} T V _{oc} I _{sc} T V _{oc} I _{sc} T mv ma °C mv ma °C mv ma °C		
0	520 129 25 605 125 -60 250 137 140			
4.210^{13}	530 125 25 605 120 -65 250 131 143	No Cell Tested		
10 ¹⁵	495 110 26 540 106 -66 215 124 144			

Table 2

Damage Coefficients (1.0 MeV Electrons)

		25 ^o C		-63 ^o C		145°C	
	e/cm ²	I _{sc(amp)}	K _(e-1)	I _{sc(amp)}	K _(e-1)	Í _{sc(amp)}	K _(e-1)
10Ω-cm bare	$4.2 10^{13} \\ 10^{15}$. 034 . 030	4.9 10-11	.031 .026	8.6 10-11	. 035	2.2 10-11
10Ω-cm cov.	$4.2 10^{13} \\ 10^{15}$. 035	5.9 10 ⁻¹¹	.032 .026	9.0 10-11	.037 .033	3.3 10-11
10Ω-cm 200μ	$4.2 10^{13} \\ 10^{15}$. 032 . 022	6. 1 10 ⁻¹¹	.030	6.3 10 ⁻¹¹	.033	2.2 10-11
10Ω-cm 50% cov	$10^{14} \\ 10^{15}$. 033 . 029	5.0 10 ⁻¹¹	.030	$1.2 \ 10^{-10}$.036	4.8 10-11
1Ω-cm bare	$10^{14} \\ 10^{15}$. 030 . 025	1.0 10-10	.028 .021	$2.0 \ 10^{-10}$. 033 . 028	7.7 10-11
1Ω-cm covered	10 ¹⁴ 10 ¹⁵	. 030 . 026	8.8 10 ⁻¹¹	.029	1.4 10 ⁻¹⁰	. 033 . 028	7.2 10^{-11}
1Ω-cm 50% cov	10 ¹⁴ 10 ¹⁵	.031 .025	1.0 10-10	.028	1.9 10 ⁻¹⁰	.034	6.4 10 ⁻¹¹

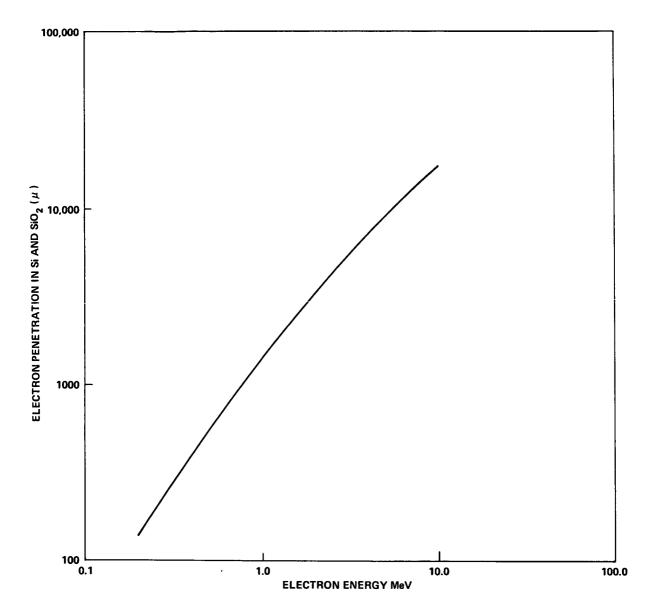


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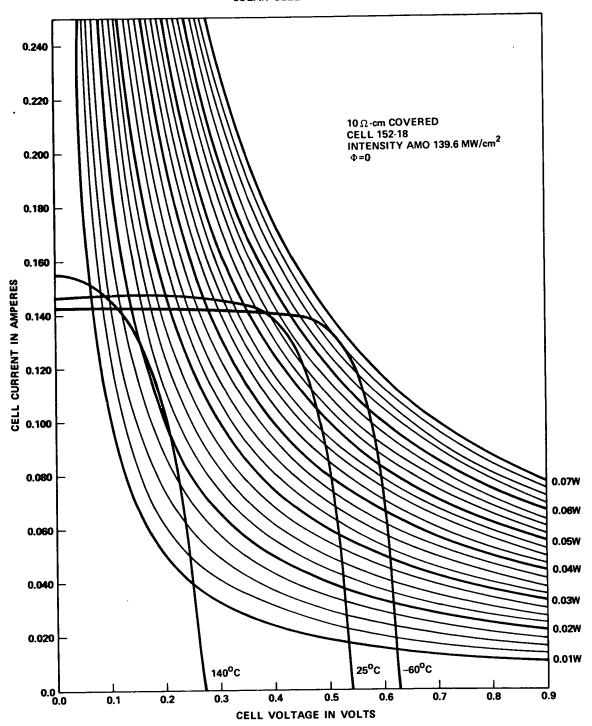


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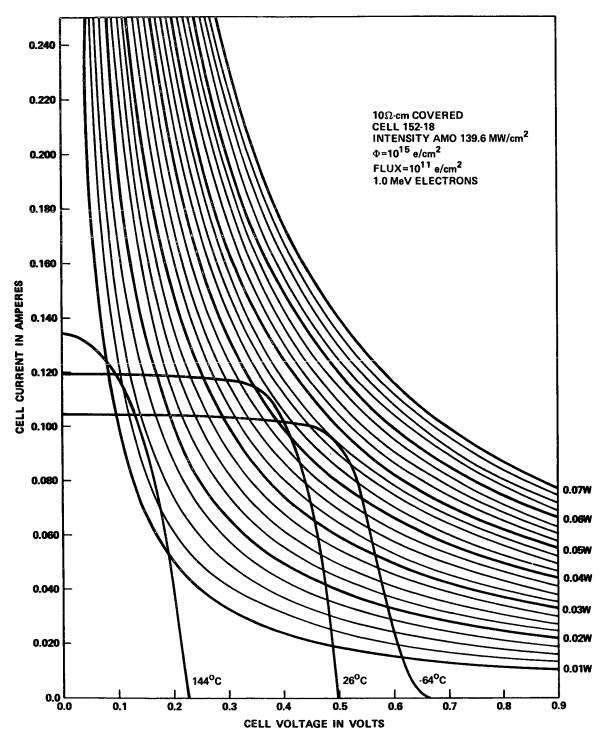


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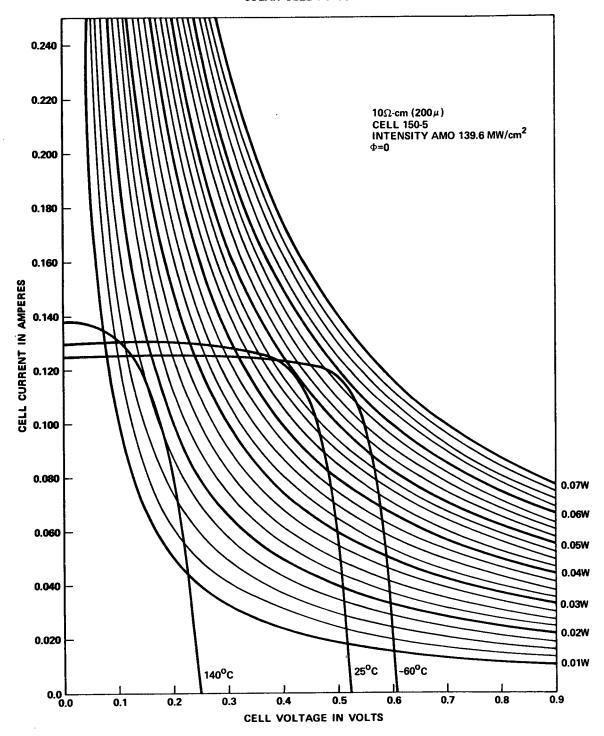


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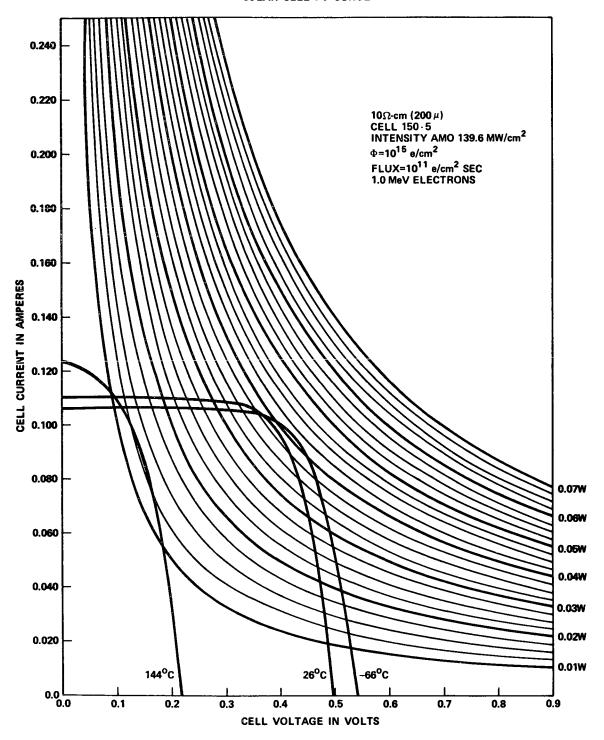


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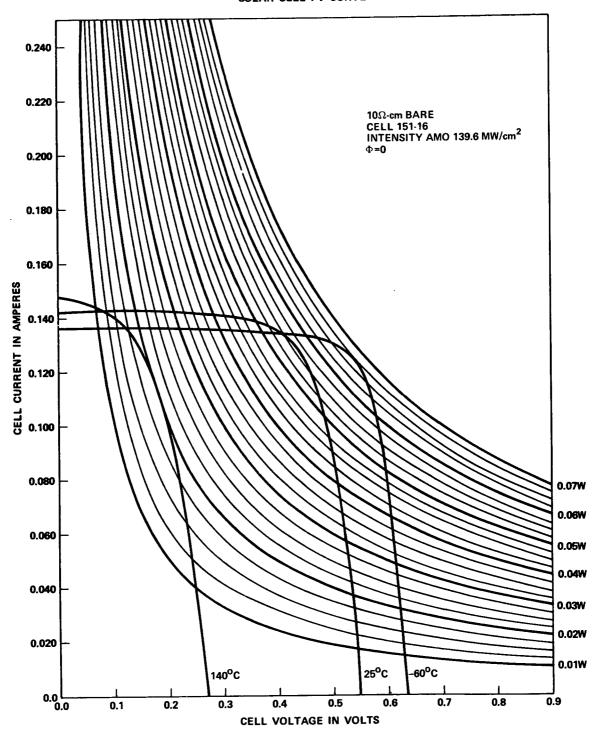


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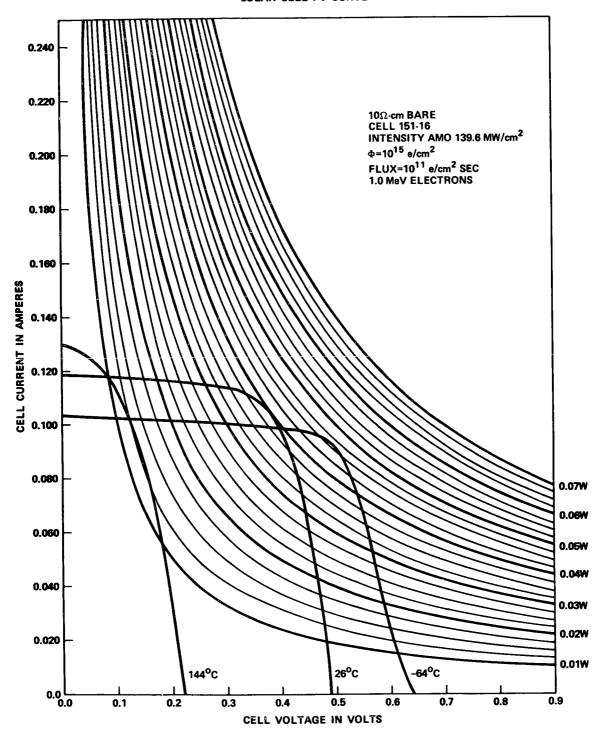


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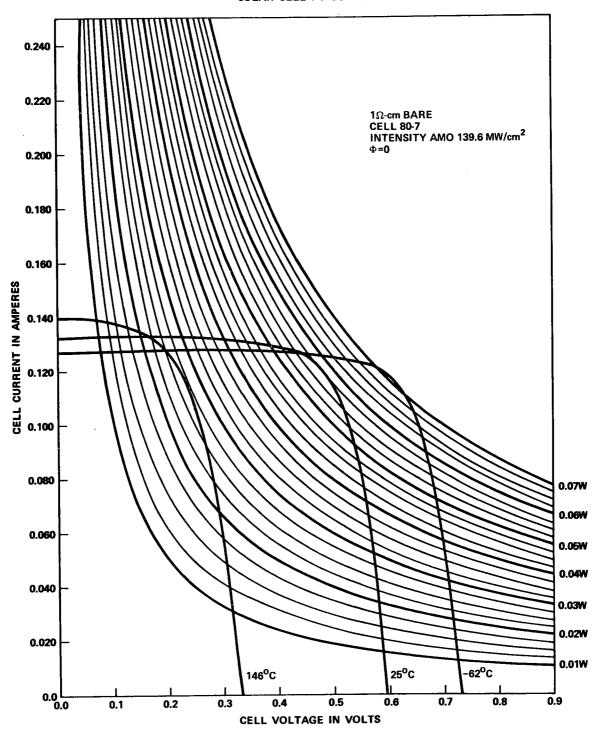


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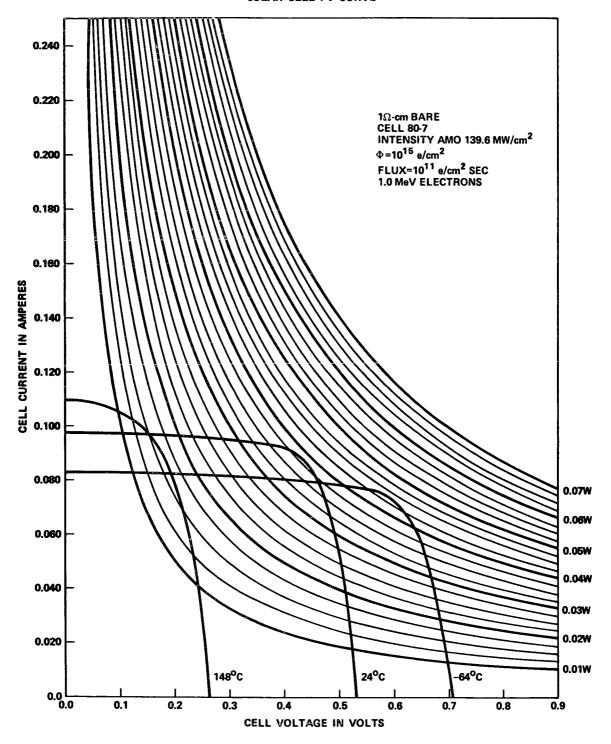


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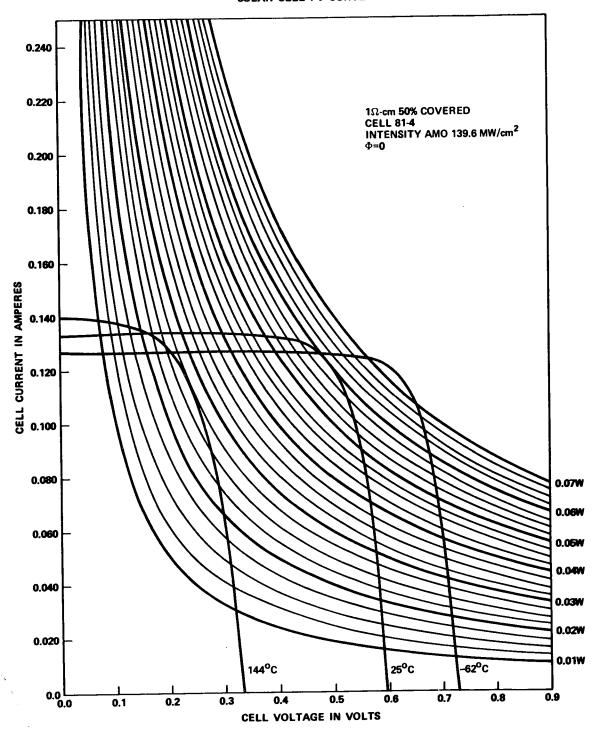


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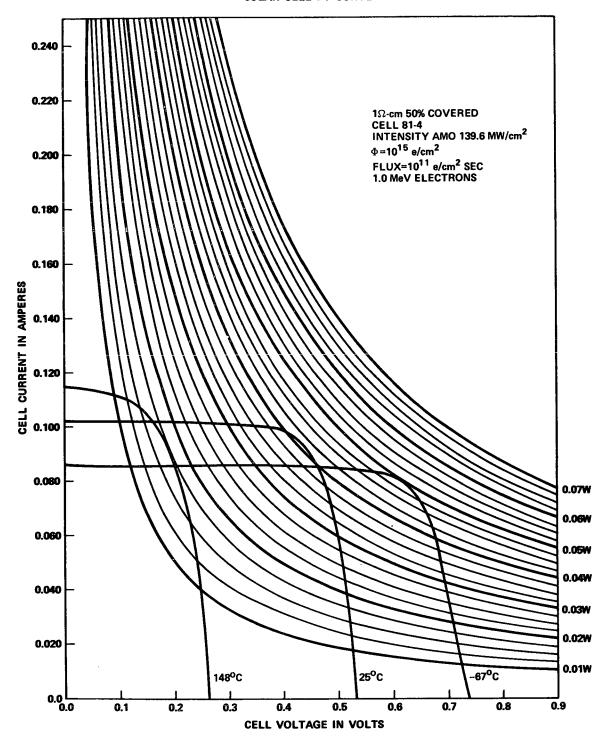


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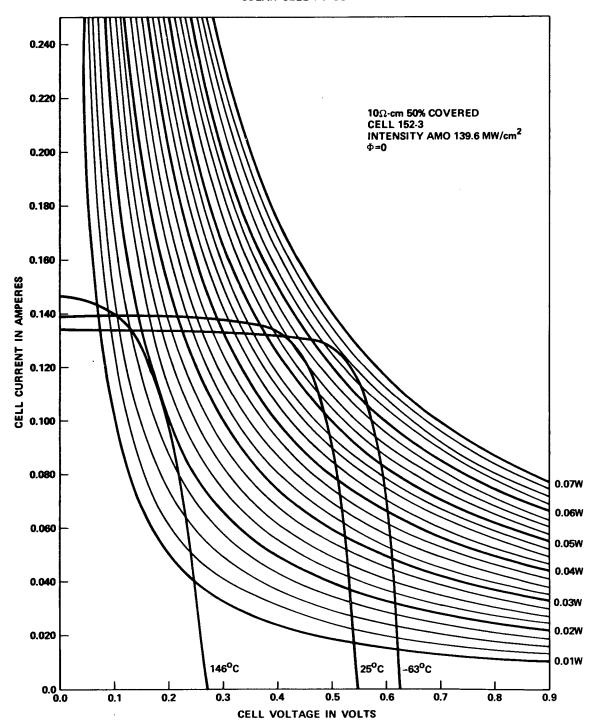


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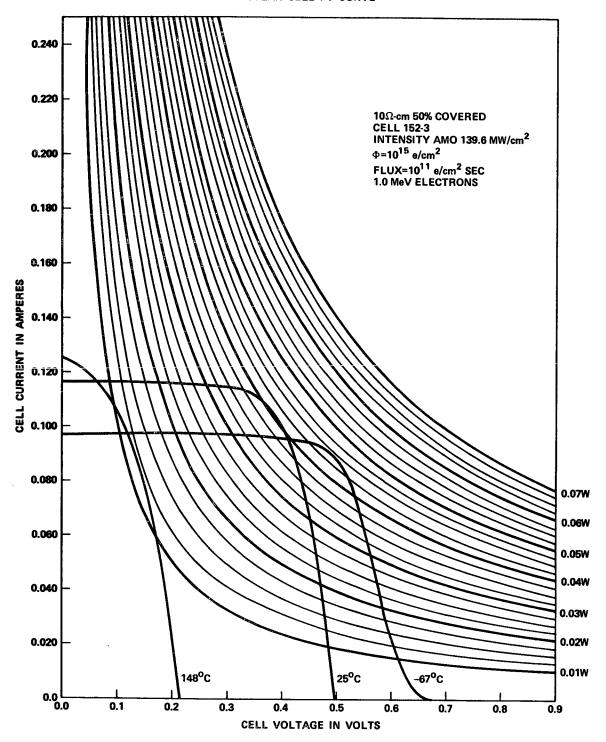


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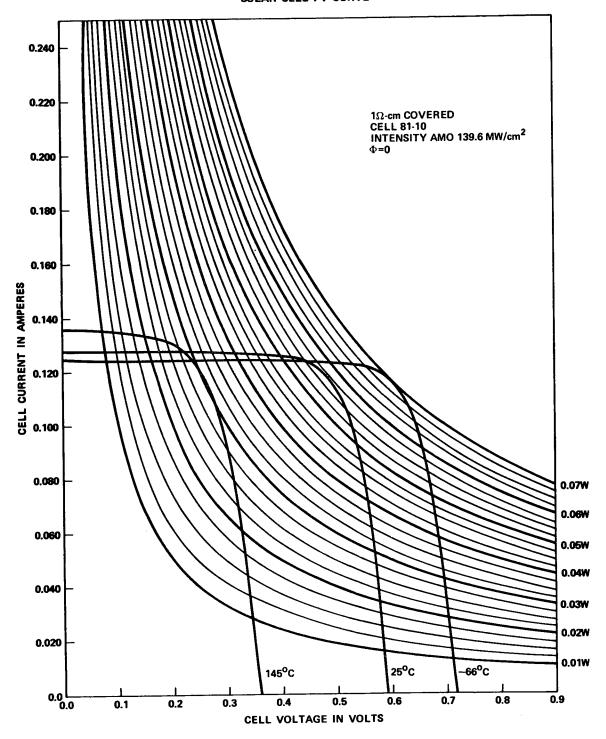


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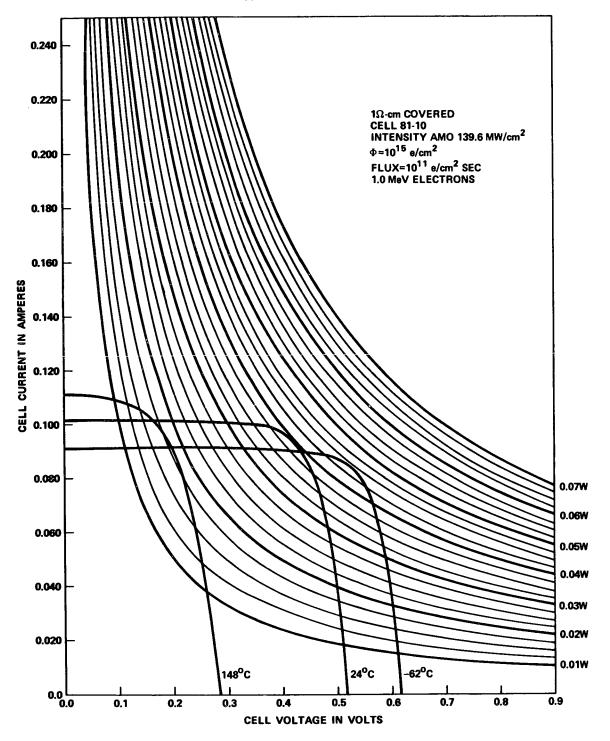


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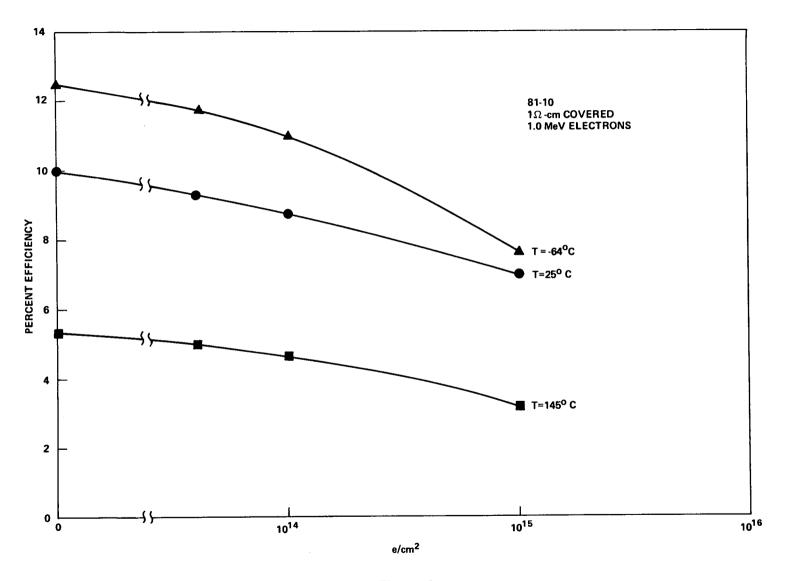


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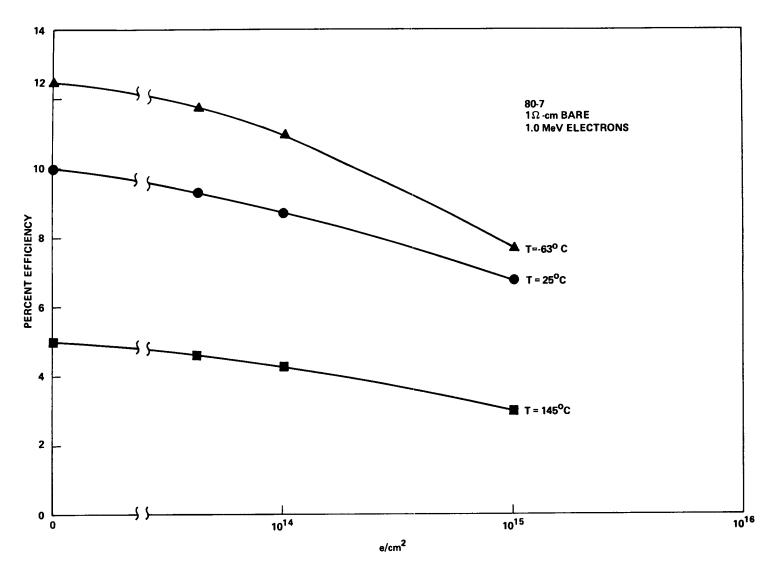


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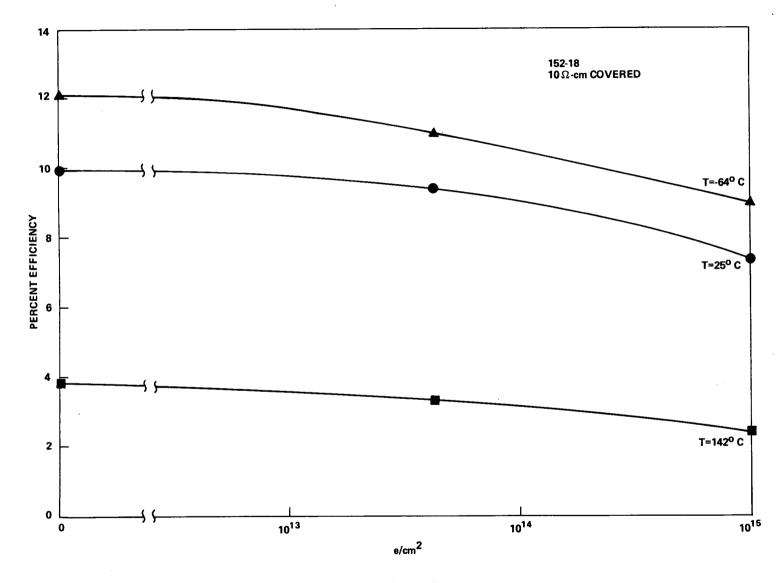


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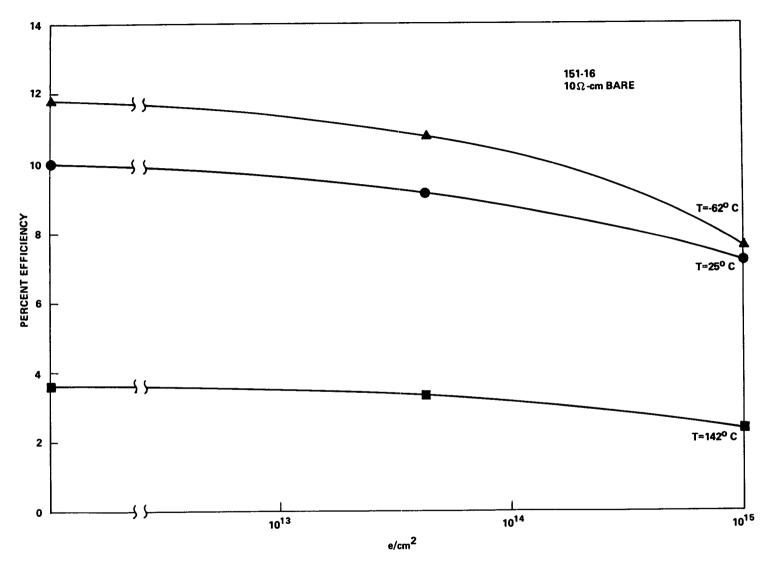


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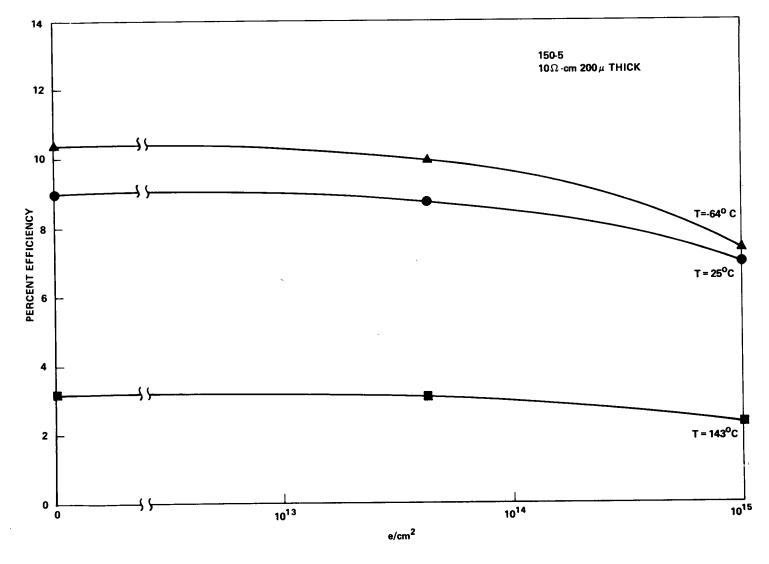


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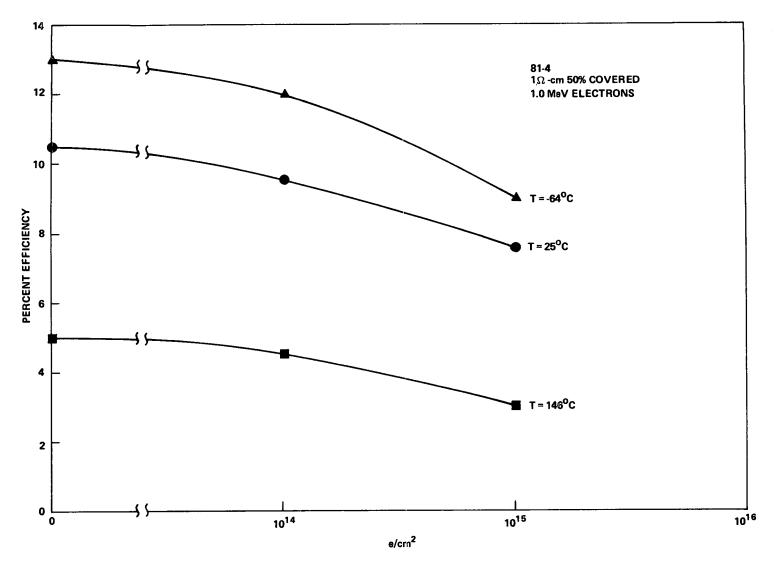


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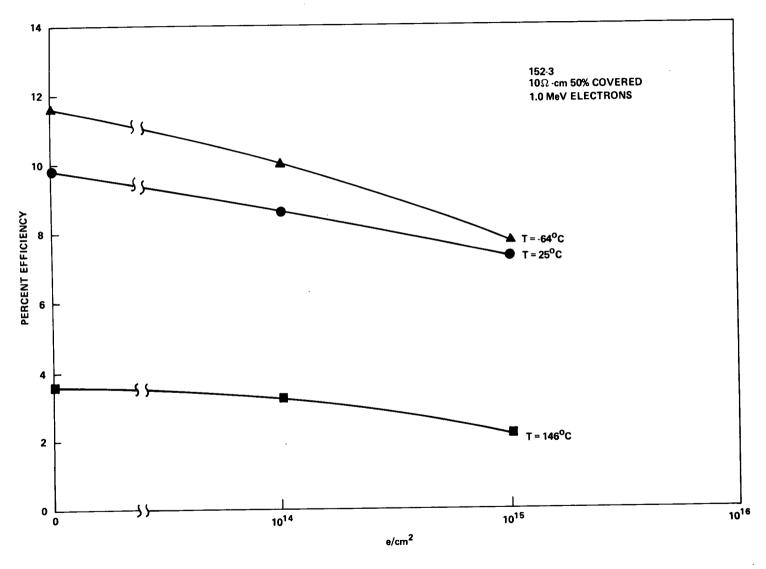


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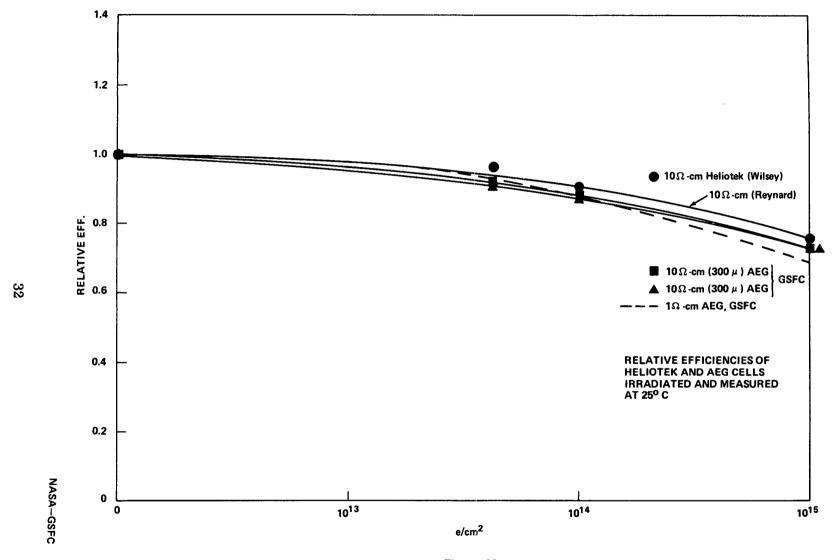


Figure 23